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WHAT IS CLAIMED IS:

- An exposure apparatus, comprising:

 a light source for producing an exposure
 beam;
- an optical system having a closed space, for projecting the exposure beam to a substrate for exposure thereof;

first supplying means for supplying an inert
gas into the closed space of said optical system; and
second supplying means for supplying one of
oxygen and a clean air, so that the inert gas and
oxygen can be supplied to the closed space.

- An apparatus according to Claim 1, wherein said optical system comprises one of an illumination optical system and a projection optical system.
- An apparatus according to Claim 1, wherein said light source comprises one of a light source for producing ultraviolet rays and a light source for producing X-rays.
- An apparatus according to Claim 3, wherein said light source comprises an ArF excimer laser light source.
 - 5. An apparatus according to Claim 1, wherein

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the inert gas comprises one of a nitrogen gas, a helium gas, and a neon gas.

- An apparatus according to Claim 1, further comprising means for mixing one of oxygen and a clean air into the inert gas.
 - 7. An apparatus according to Claim 6, further comprising a supplying line for supplying the inert gas into the closed space, wherein the oxygen or clean air is introduced from a line branched from the supplying line, for mixture of the same into the inert gas.
 - 8. An apparatus according to Claim 1, further comprising means for discharging the gas inside the closed space outwardly.
 - 9. An apparatus according to Claim 8, further comprising means for transforming ozone remaining in the discharged gas into oxygen for reuse thereof.
 - $10.\,\,$ An apparatus according to Claim 1, further comprising means for changing the wavelength of the exposure beam.
 - 11. An apparatus according to Claim 10, wherein,

when the oxygen is supplied, the wavelength of exposure beam is changed into a wavelength region higher than an oxygen absorptivity.

- 5 12. An apparatus according to Claim 10, wherein, when the oxygen is supplied, the wavelength of exposure beam is changed to s shorter wavelength.
 - 13. A device manufacturing method comprising the steps of:

 $\label{eq:preparing an exposure apparatus as recited in $$ Claim 1; and $$$

performing an exposure process by use of the $\ensuremath{\mathsf{exposure}}$ apparatus.

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14. A method according to Claim 13, further comprising applying a resist to a substrate, before the exposure process, and developing the substrate after the exposure process.

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15. A method of cleaning an optical element of an exposure apparatus for exposing a substrate with an exposure beam of ultraviolet rays or X-rays, projected thereto, said method comprising the steps of:

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supplying an inert gas containing a small amount of oxygen into a space in which the optical element is placed;

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projecting the exposure beam so that ozone is produced in the space; and

removing an organic compound deposited on the optical element through photochemical reaction by projection of the exposure beam and the produced ozone.

- 16. A method according to Claim 15, further comprising changing a wavelength of the exposure beam, between exposure of the substrate and the cleaning of the optical element.
- 17. A method according to Claim 16, wherein the wavelength of exposure beam is changed by one of controlling actuation of a light source for producing the exposure beam and inserting wavelength changing means to a light path.
- 18. A method according to Claim 15, further comprising discharging the removed organic compound outwardly of the space.

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